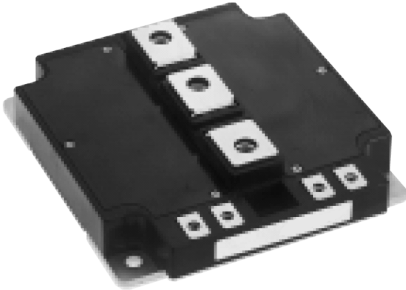


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CM800DY-24S

HIGH POWER SWITCHING USE
INSULATED TYPE



Dual (Half-Bridge)

Collector current I_C **790 A***
 Collector-emitter voltage V_{CES} **1200 V**
 Maximum junction temperature T_{jmax} **175 °C**

- Flat base Type
- Copper base plate
- RoHS Directive compliance
- UL Recognized under UL1557, File E323585

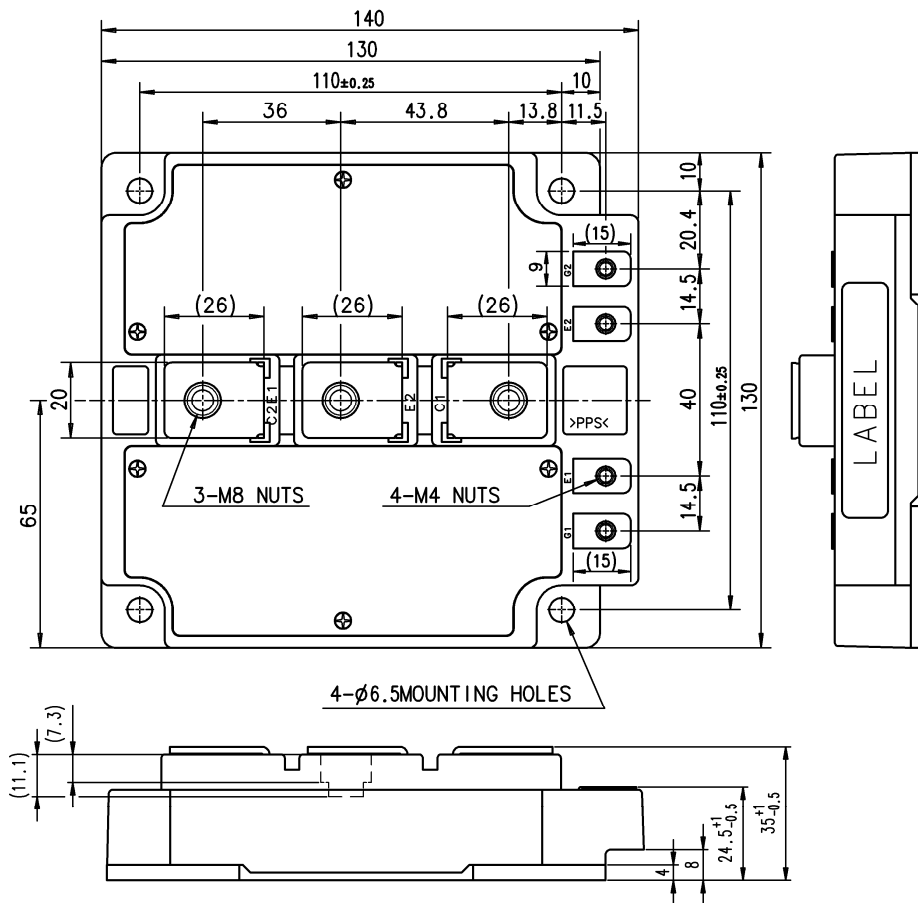
*. DC current rating is limited by power terminals.

APPLICATION

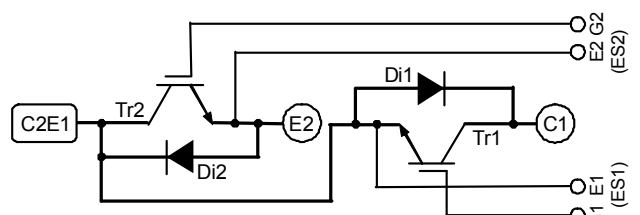
AC Motor Control, Motion/Servo Control, Power supply, etc.

OUTLINE DRAWING & INTERNAL CONNECTION

Dimension in mm



INTERNAL CONNECTION



Tolerance otherwise specified

Division of Dimension	Tolerance
0.5 to 3	±0.2
over 3 to 6	±0.3
over 6 to 30	±0.5
over 30 to 120	±0.8
over 120 to 400	±1.2

< IGBT MODULES >

CM800DY-24S

HIGH POWER SWITCHING USE
INSULATED TYPE

ABSOLUTE MAXIMUM RATINGS (T_j=25 °C, unless otherwise specified)

Symbol	Item	Conditions	Rating	Unit
V _{CES}	Collector-emitter voltage	G-E short-circuited	1200	V
V _{GES}	Gate-emitter voltage	C-E short-circuited	±20	V
I _C	Collector current	DC, T _C =117 °C (Note.2, 4)	790 *	A
I _{CRM}		Pulse, Repetitive (Note.3)	1600	
P _{tot}	Total power dissipation	T _C =25 °C (Note.2, 4)	5355	W
I _E (Note.1)	Emitter current	T _C =25 °C (Note.2, 4)	790 *	A
I _{ERM} (Note.1)		Pulse, Repetitive (Note.3)	1600	
V _{isol}	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	2500	V
T _{jmax}	Maximum junction temperature	-	175	°C
T _{cmax}	Maximum case temperature	(Note.2)	125	
T _{jopr}	Operating junction temperature	-	-40 ~ +150	°C
T _{stg}	Storage temperature	-	-40 ~ +125	

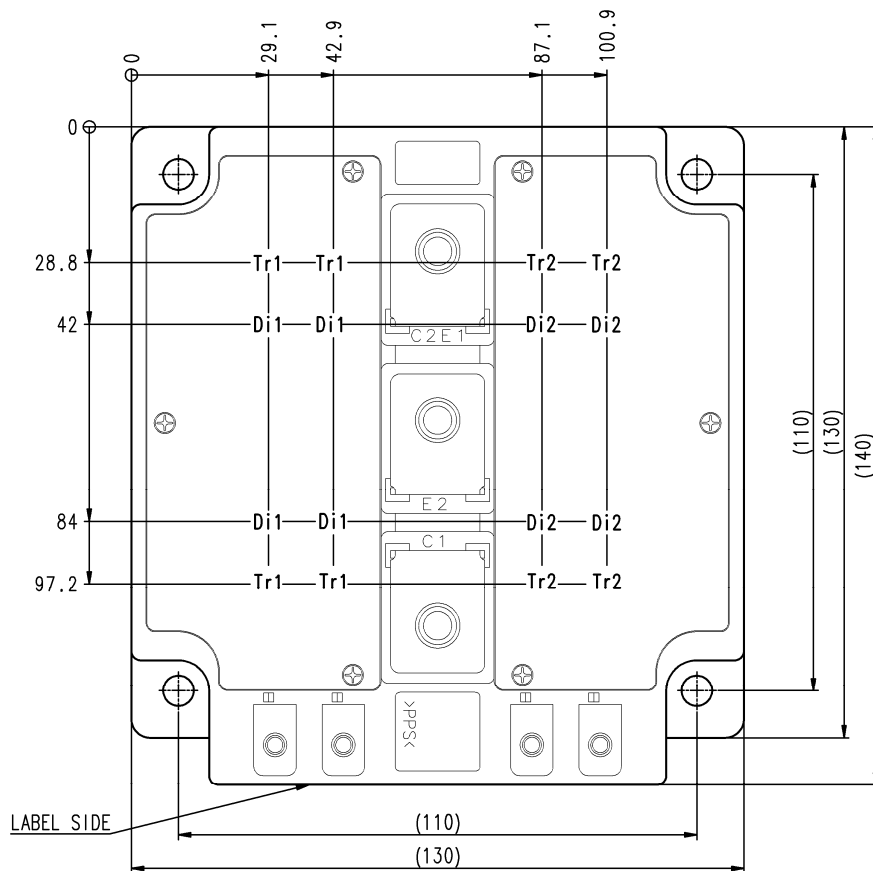
ELECTRICAL CHARACTERISTICS (T_j=25 °C, unless otherwise specified)

Symbol	Item	Conditions	Limits			Unit	
			Min.	Typ.	Max.		
I _{CES}	Collector-emitter cut-off current	V _{CE} =V _{CES} , G-E short-circuited	-	-	1.0	mA	
I _{GES}	Gate-emitter leakage current	V _{GE} =V _{GES} , C-E short-circuited	-	-	0.5	µA	
V _{GE(th)}	Gate-emitter threshold voltage	I _C =80 mA, V _{CE} =10 V	5.4	6.0	6.6	V	
V _{CESat}	Collector-emitter saturation voltage	I _C =800 A (Note.5), V _{GE} =15 V, Terminal	T _j =25 °C	-	1.95	2.40	V
			T _j =125 °C	-	2.25	-	
			T _j =150 °C	-	2.35	-	
		I _C =800 A (Note.5), V _{GE} =15 V, Chip	T _j =25 °C	-	1.70	2.15	V
			T _j =125 °C	-	1.90	-	
			T _j =150 °C	-	1.95	-	
C _{ies}	Input capacitance	V _{CE} =10 V, G-E short-circuited	-	-	80	nF	
C _{oes}	Output capacitance		-	-	16		
C _{res}	Reverse transfer capacitance		-	-	1.32		
Q _G	Gate charge	V _{CC} =600 V, I _C =800 A, V _{GE} =15 V	-	1868	-	nC	
t _{d(on)}	Turn-on delay time	V _{CC} =600 V, I _C =800 A, V _{GE} =±15 V, R _G =0 Ω, Inductive load	-	-	800	ns	
t _r	Rise time		-	-	200		
t _{d(off)}	Turn-off delay time		-	-	600		
t _f	Fall time		-	-	300		
V _{EC} (Note.1)	Emitter-collector voltage	I _E =800 A (Note.5), G-E short-circuited, Terminal	T _j =25 °C	-	1.85	2.30	V
			T _j =125 °C	-	1.85	-	
			T _j =150 °C	-	1.85	-	
		I _E =800 A (Note.5), G-E short-circuited, Chip	T _j =25 °C	-	1.70	2.15	V
			T _j =125 °C	-	1.70	-	
			T _j =150 °C	-	1.70	-	
t _{rr} (Note.1)	Reverse recovery time	V _{CC} =600 V, I _E =800 A, V _{GE} =±15 V, R _G =0 Ω, Inductive load	-	-	300	ns	
Q _{rr} (Note.1)	Reverse recovery charge	R _G =0 Ω, Inductive load	-	42.8	-	µC	
E _{on}	Turn-on switching energy per pulse	V _{CC} =600 V, I _C =I _E =800 A, V _{GE} =±15 V, R _G =0 Ω,	-	107	-	mJ	
E _{off}	Turn-off switching energy per pulse	T _j =150 °C, Inductive load	-	82	-		
E _{rr} (Note.1)	Reverse recovery energy per pulse	T _j =150 °C, Inductive load	-	71	-	mJ	
R _{CC'+EE'}	Internal lead resistance	Main terminals -chip, per switch, T _C =25 °C	-	-	0.4	mΩ	
r _G	Internal gate resistance	Per switch	-	2.45	-	Ω	

< IGBT MODULES >
CM800DY-24S
 HIGH POWER SWITCHING USE
 INSULATED TYPE

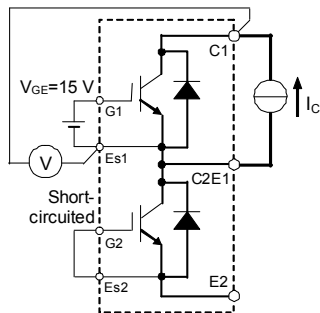
CHIP LOCATION (Top view)

Dimension in mm, tolerance: ± 1 mm



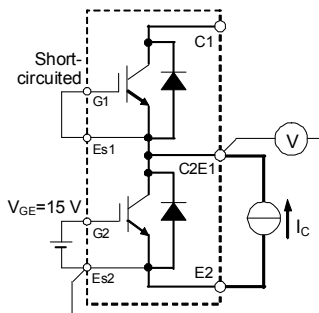
Tr1/Tr2: IGBT, Di1/Di2: FWDi

TEST CIRCUIT

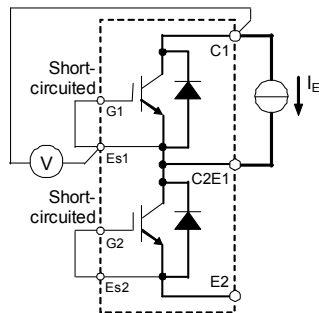


Tr1

V_{CEsat} test circuit

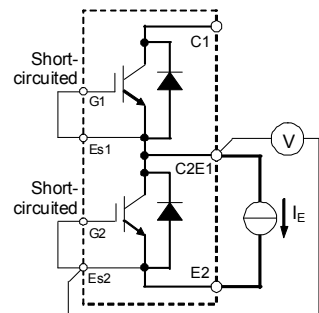


Tr2



Di1

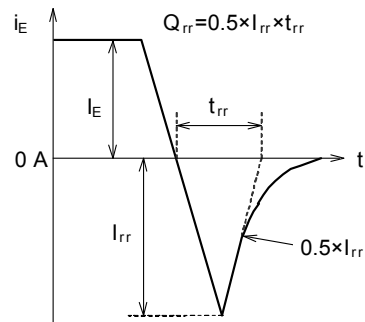
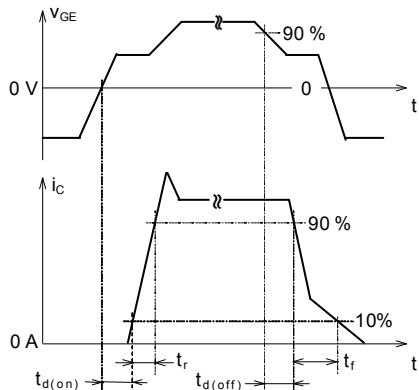
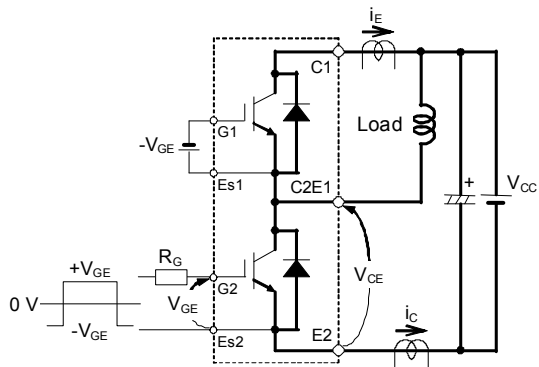
V_{EC} test circuit



Di2

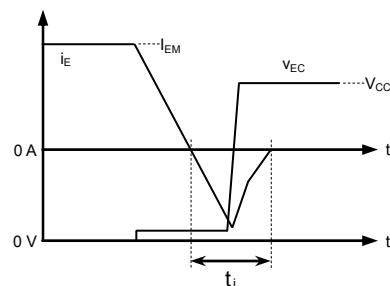
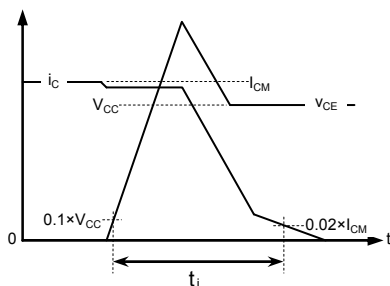
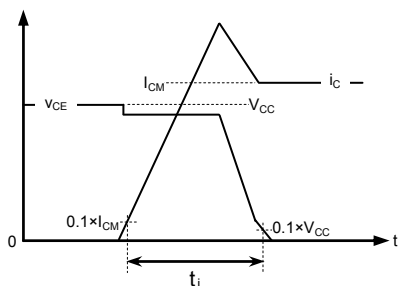
< IGBT MODULES >
CM800DY-24S
 HIGH POWER SWITCHING USE
 INSULATED TYPE

TEST CIRCUIT AND WAVEFORMS



Switching characteristics test circuit and waveforms

t_{rr}, Q_{rr} test waveform



IGBT Turn-on switching energy

IGBT Turn-off switching energy

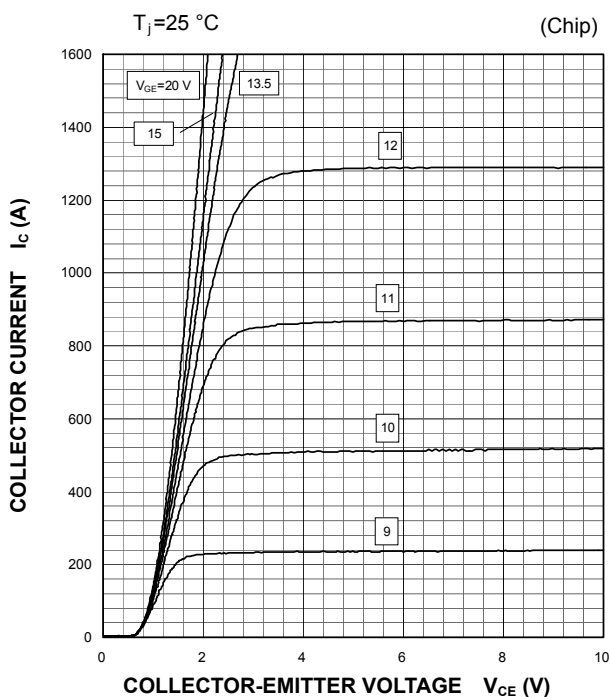
FWDI Reverse recovery energy

Turn-on / Turn-off switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

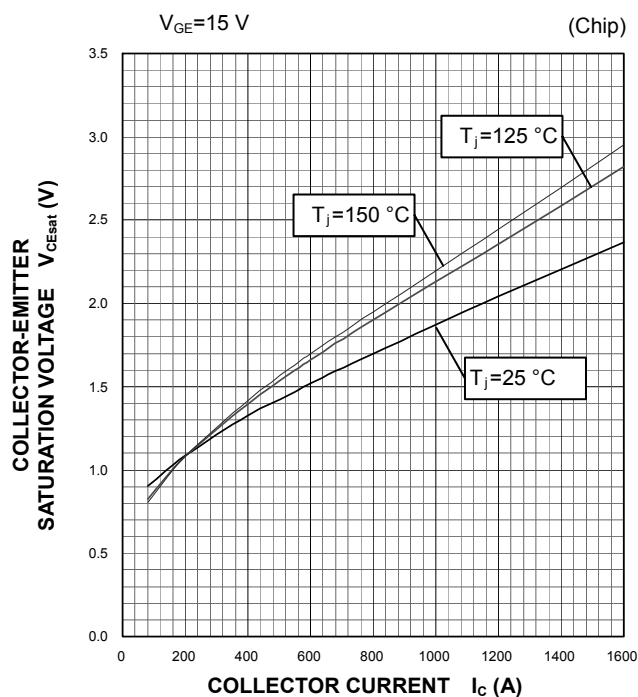
< IGBT MODULES >
CM800DY-24S
 HIGH POWER SWITCHING USE
 INSULATED TYPE

PERFORMANCE CURVES

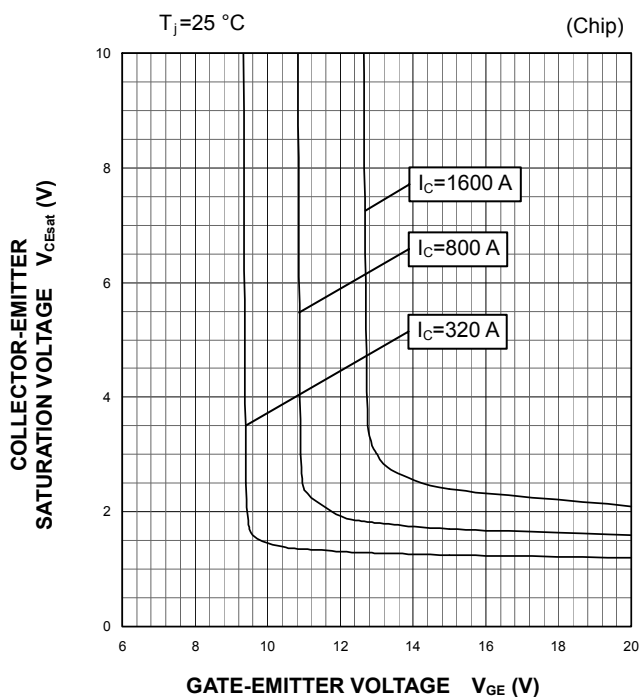
OUTPUT CHARACTERISTICS
(TYPICAL)



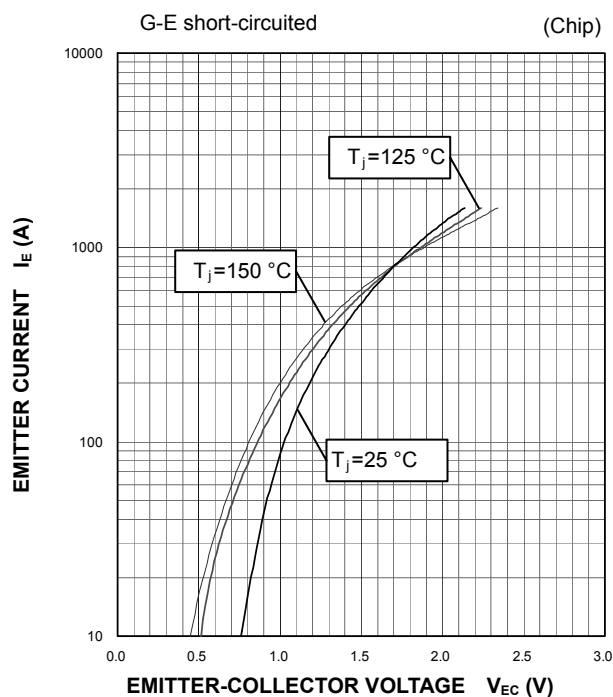
COLLECTOR-EMITTER SATURATION
VOLTAGE CHARACTERISTICS
(TYPICAL)



COLLECTOR-EMITTER SATURATION
VOLTAGE CHARACTERISTICS
(TYPICAL)



FREE WHEELING DIODE
FORWARD CHARACTERISTICS
(TYPICAL)

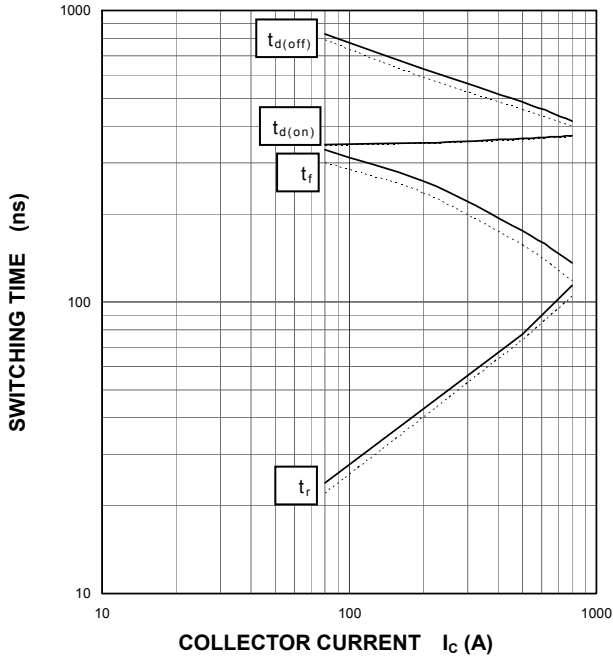


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CM800DY-24S
 HIGH POWER SWITCHING USE
 INSULATED TYPE

PERFORMANCE CURVES

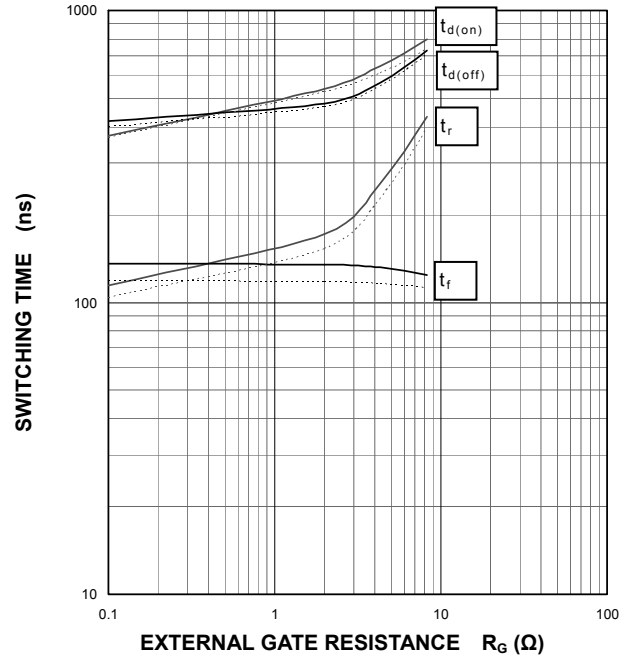
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

$V_{CC}=600\text{ V}$, $V_{GE}=\pm 15\text{ V}$, $R_G=0\ \Omega$, INDUCTIVE LOAD
 —: $T_j=150\text{ }^\circ\text{C}$, - - - -: $T_j=125\text{ }^\circ\text{C}$



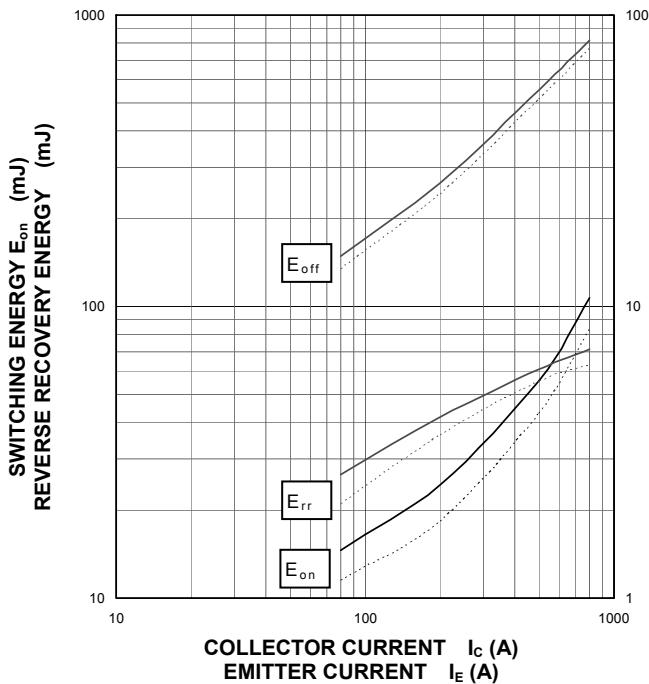
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

$V_{CC}=600\text{ V}$, $I_C=800\text{ A}$, $V_{GE}=\pm 15\text{ V}$, INDUCTIVE LOAD
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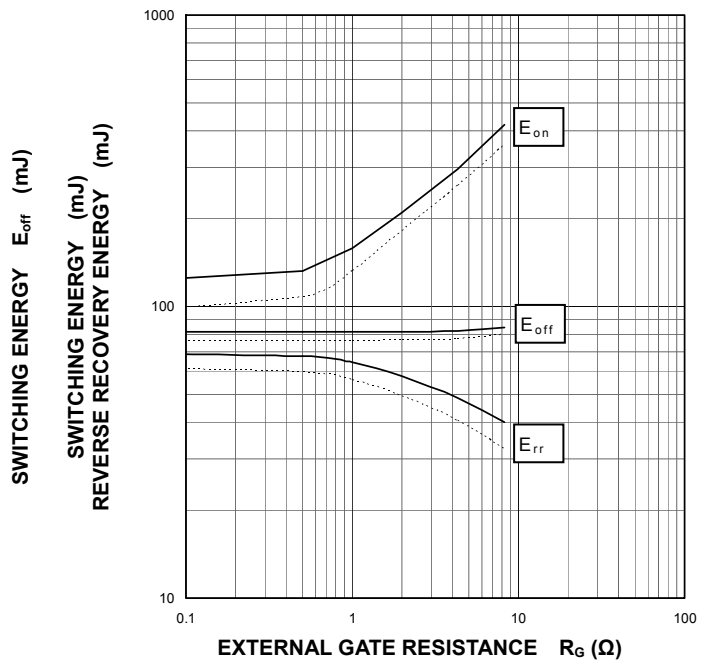
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

$V_{CC}=600\text{ V}$, $V_{GE}=\pm 15\text{ V}$, $R_G=0\ \Omega$,
 INDUCTIVE LOAD, PER PULSE
 —: $T_j=150\text{ }^\circ\text{C}$, - - - -: $T_j=125\text{ }^\circ\text{C}$



HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

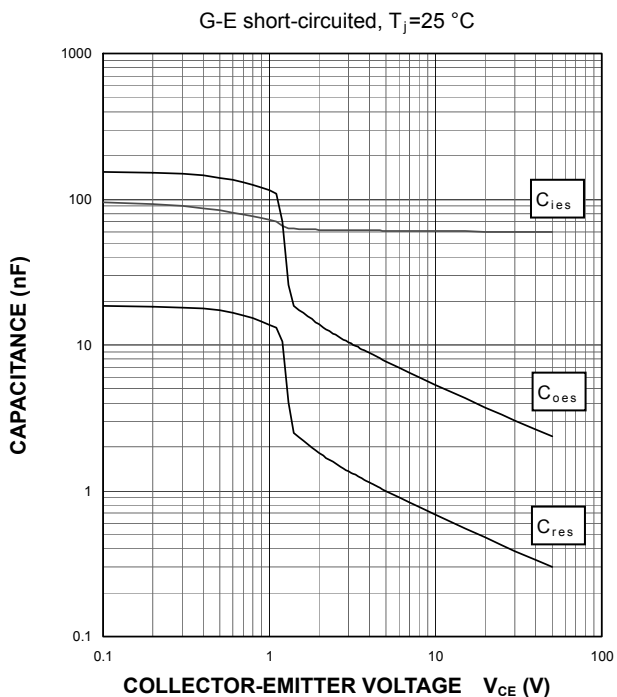
$V_{CC}=600\text{ V}$, $I_C/I_E=800\text{ A}$, $V_{GE}=\pm 15\text{ V}$,
 INDUCTIVE LOAD, PER PULSE
 —: $T_j=150\text{ }^\circ\text{C}$, - - - -: $T_j=125\text{ }^\circ\text{C}$



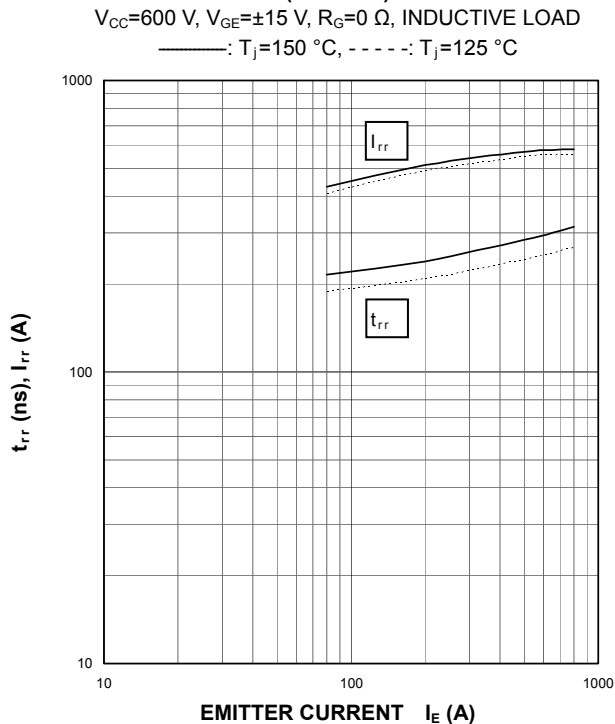
< IGBT MODULES >
CM800DY-24S
 HIGH POWER SWITCHING USE
 INSULATED TYPE

PERFORMANCE CURVES

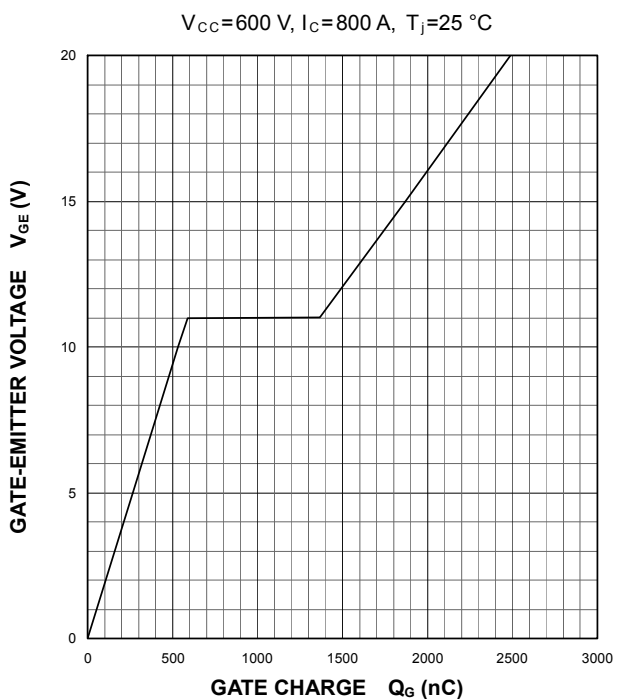
CAPACITANCE CHARACTERISTICS (TYPICAL)



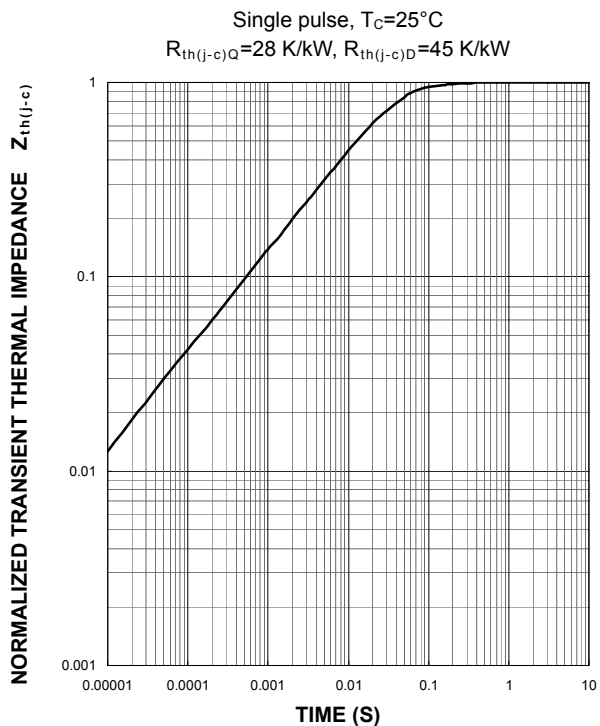
FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



GATE CHARGE CHARACTERISTICS (TYPICAL)



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)



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